

IGBT Discrete with Anti-Parallel Diode

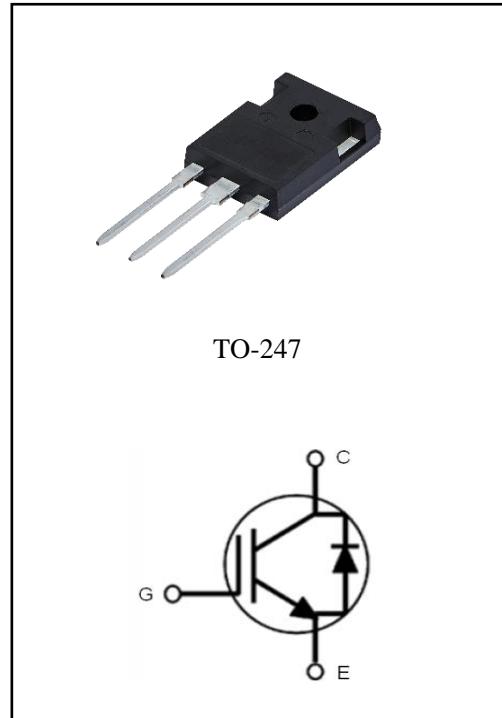
$V_{CES}=700V$, $I_C \text{ nom}=40A$ / $I_{CRM}=120A$

Features :

- 700V Trench /Field Stop type
- Low switching losses
- V_{cesat} has a positive temperature coefficient

Applications:

- Charging station
- OBC
- Uninterruptible power supplies
- Inverters



IGBT

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Collector-Emitter voltage	$T_{vj}=25^\circ C$	V_{CES}	700	V
Continuous DC collector current	$T_c=100^\circ C$, $T_{vj \max}=175^\circ C$	$I_C \text{ nom}$	40	A
Repetitive peak collector current	$t_p=1 \text{ ms}$	I_{CRM}	120	A
Gate emitter voltage	$t_p \leq 0.5 \mu s$, $D < 0.001$	V_{GE}	± 20 ± 30	V

Power dissipation	T _c =25°C T _c =100°C	P _{tot}	294 147	W
Temperature under switching conditions		T _{vj op}	-40...+175	°C
Storage temperature		T _{stg}	-40...+150	°C

Thermal Characteristics

Parameter	Conditions	Symbol	Value	Unit
IGBT thermal resistance, junction - case		R _{th(j-C)}	0.51	K/W
Diode thermal resistance, junction - case		R _{th(j-C)}	0.42	K/W

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Collector-Emitter saturation voltage	V _{GE} =15V, I _c =40A V _{GE} =15V, I _c =40A V _{GE} =15V, I _c =40A	T _{vj} =25°C T _{vj} =150°C T _{vj} =175°C	V _{CEsat}	1.42 1.70 1.73	1.80	V
Gate-Emitter threshold voltage	I _c =0.4mA, V _{GE} = V _{CE}	T _{vj} =25°C	V _{GE(th)}	4.3	4.9	5.5
Transconductance	V _{CE} =20V, I _c =40A	G _{fs}		67		S
Input capacitance	f=100kHz, V _{CE} =25 V, V _{GE} =0 V	C _{ies}		5514		pF
Output capacitance		C _{oes}		202		pF
Reverse transfer capacitance		C _{res}		93		pF
Gate charge	I _c = 40A, V _{GE} = 15 V, V _{CE} = 560V	T _{vj} =25°C	Q _G		533	nC
Collector-emitter cut-off current	V _{CE} =700V, V _{GE} = 0 V	T _{vj} =25°C	I _{CES}		1	mA
Gate-emitter leakage current	V _{CE} =0 V, V _{GE} = 20 V	T _{vj} =25°C	I _{GES}		200	nA
Turn-on delay time	I _c =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =175°C	t _{d(on)}		24 20	ns
Rise time	I _c =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =175°C	t _r		61 56	ns

Turn-off delay time	I _C =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =175°C	t _{d(off)}		148 172		ns
Fall time	I _C =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =175°C	t _f		41 77		ns
Turn-on energy loss per pulse	I _C =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω di/dt=600A/us(T _{vj} =175°C) (inductive load)	T _{vj} =25°C T _{vj} =175°C	E _{on}		1.31 2.83		mJ
Turn-off energy loss per pulse	I _C =40A, V _{CE} =400V V _{GE} =±15 V, R _G =8Ω dv/dt=9000V/us(T _{vj} =175°C) (inductive load)	T _{vj} =25°C T _{vj} =175°C	E _{off}		0.51 0.74		mJ

Diode

Maximum Ratings

Parameter	Conditions	Symbol	Value		Unit
Repetitive peak reverse voltage	T _{vj} =25°C	V _{RRM}	700		V
Continuous DC forward current	T _C =100°C, T _{vj max} =175°C	I _F	40		A
Repetitive peak forward current	t _p =1ms	I _{FRM}	120		A

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	I _F =40A, V _{GE} =0V I _F =40A, V _{GE} =0V I _F =40A, V _{GE} =0V	T _{vj} =25°C T _{vj} =150°C T _{vj} =175°C	V _F	1.52 1.23 1.19	2.00	V
Peak reverse recovery current	I _F =40A, -dI _F /dt=600A/μs(T _{vj} =175°C) V _R =400V, V _{GE} =-15V	T _{vj} =25°C T _{vj} =175°C	I _{RM}	15.36 41.28		A
Reverse Recovered charge	I _F =40A, -dI _F /dt=600A/μs(T _{vj} =175°C) V _R =400V, V _{GE} =-15V	T _{vj} =25°C T _{vj} =175°C	Q _{rr}	0.96 5.39		μC
Reverse Recovery Time	I _F =40A, -dI _F /dt=600A/μs(T _{vj} =175°C) V _R =400V, V _{GE} =-15V	T _{vj} =25°C T _{vj} =175°C	t _{rr}	119 200		ns
Reverse recovered energy	I _F =40A, -dI _F /dt=600A/μs(T _{vj} =175°C) V _R =400V, V _{GE} =-15V	T _{vj} =25°C T _{vj} =175°C	E _{rec}	0.22 1.13		mJ

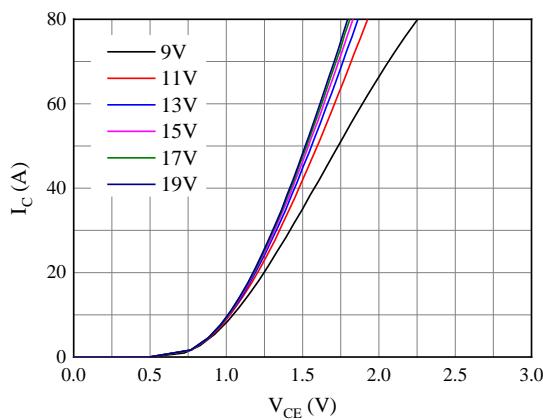


Fig 1. Typical output characteristics ($T_{vj}=25^\circ\text{C}$)

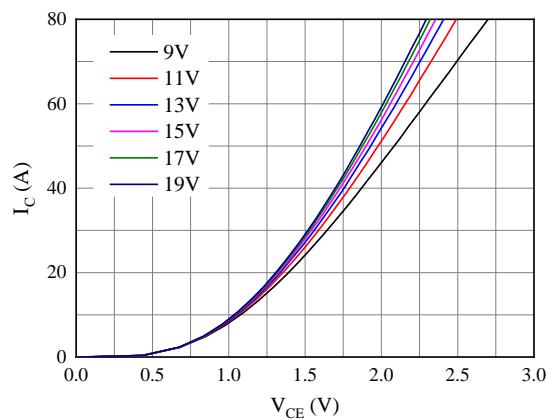


Fig 2. Typical output characteristics ($T_{vj}=175^\circ\text{C}$)

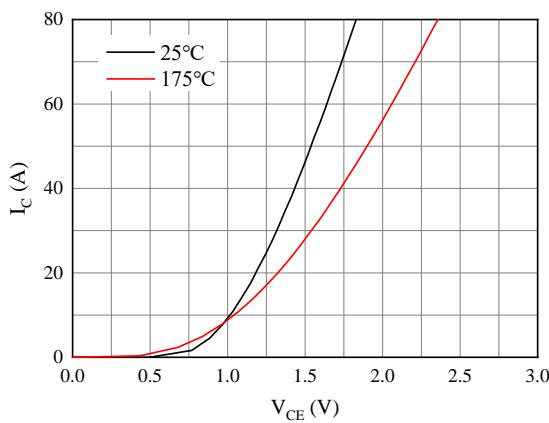


Fig 3. Typical output characteristics ($V_{GE}=15\text{V}$)

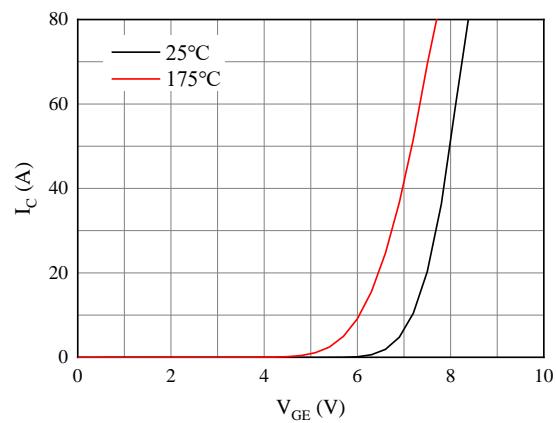


Fig 4. Typical transfer characteristic($V_{CE}=20\text{V}$)

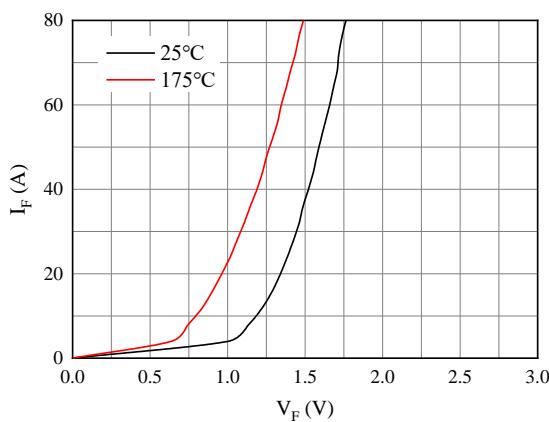


Fig 5. Forward characteristic of Diode

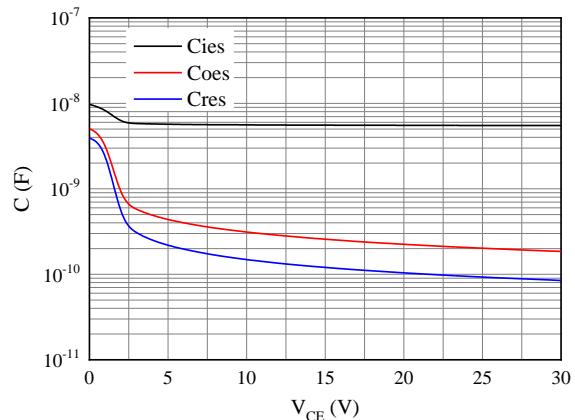


Fig 6. Capacitance characteristic

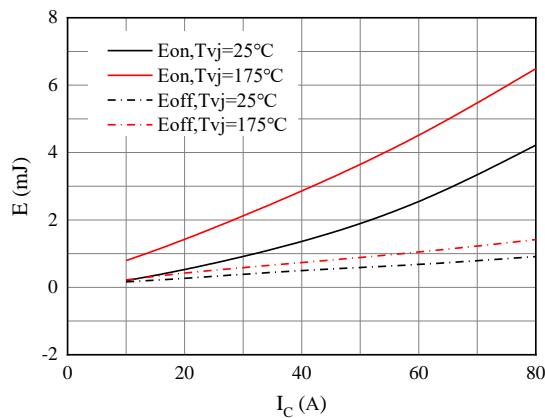


Fig 7. Switching losses of IGBT

V_{GE}=±15V, R_{gon}=8Ω, R_{goff}=8Ω, V_{CE}=400V

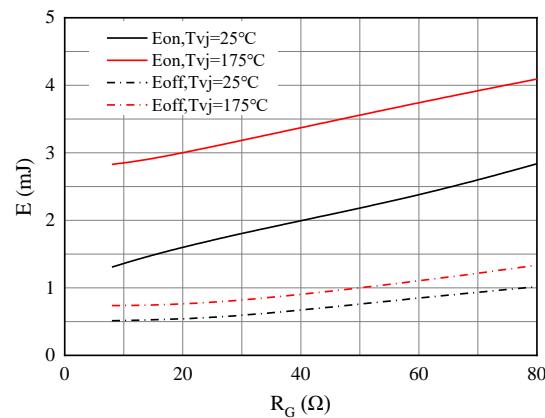


Fig 8. Switching losses of IGBT

V_{GE}=±15V, I_C=40A, V_{CE}=400V

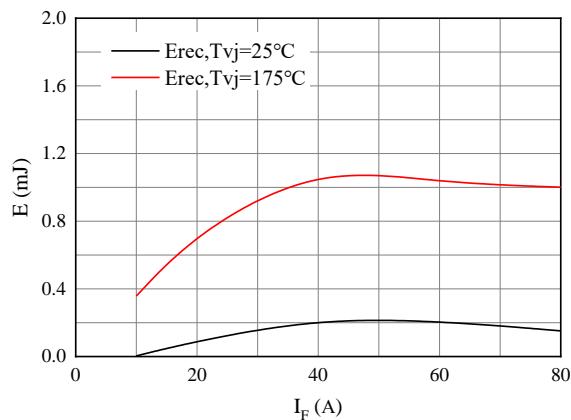


Fig 9. Switching losses of Diode

R_{gon}=8Ω, V_{CE}=400V

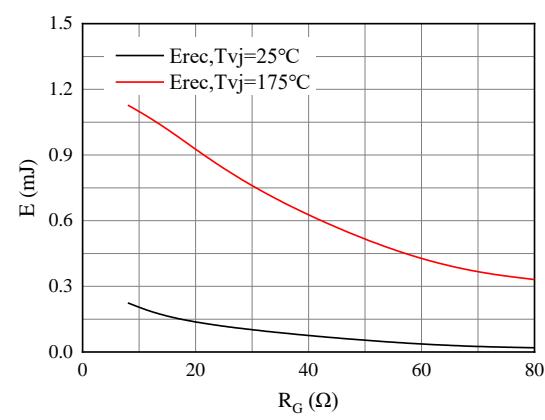


Fig 10. Switching losses of Diode

I_F=40A, V_{CE}=400V

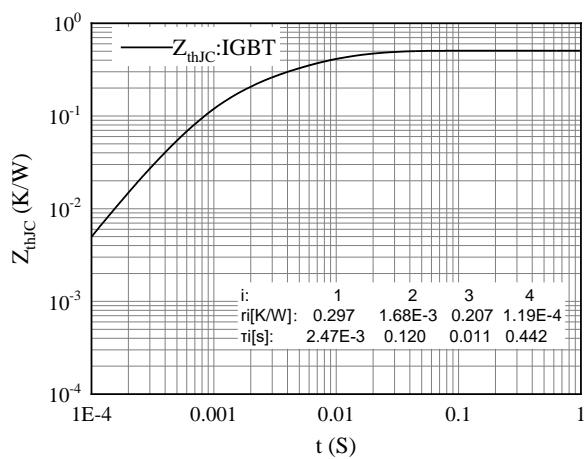


Fig 11. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$

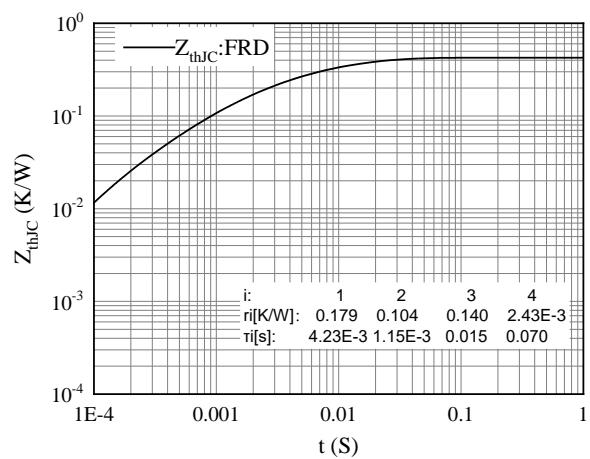
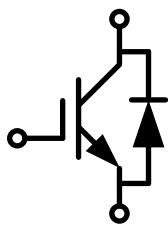
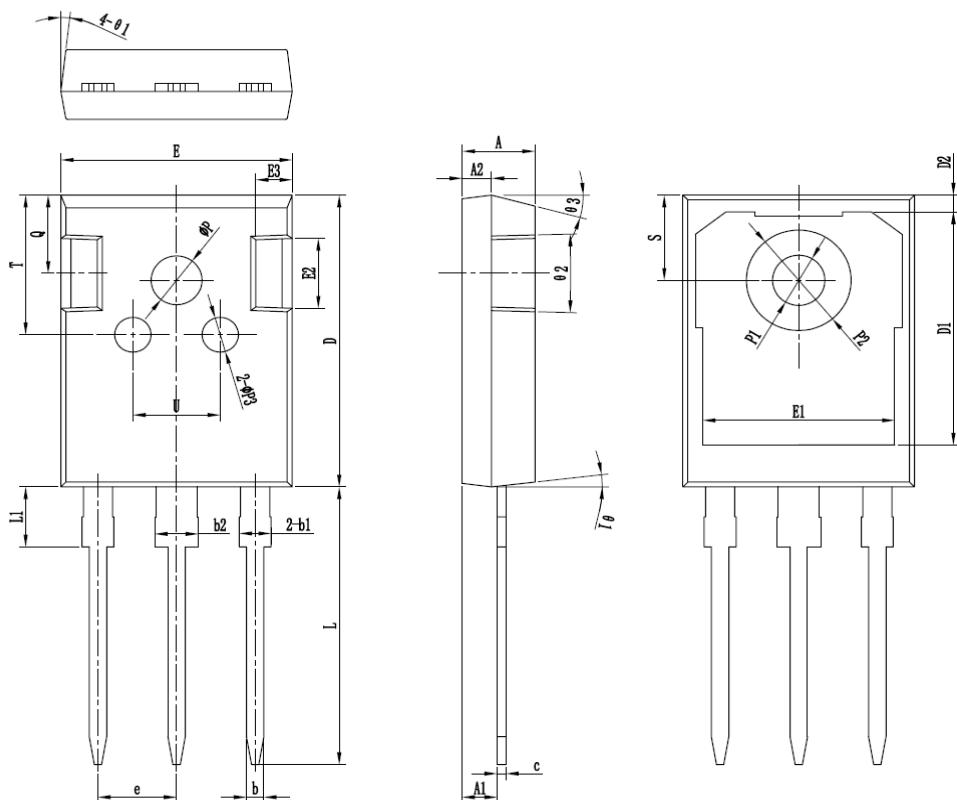


Fig 12. Transient thermal impedance FRD,
 $Z_{thJC}=f(t)$

Circuit diagram

Package outlines


symbol	unit: mm		
	MIN	NOM	MAX
a ₁	4.90	5.00	5.10
a ₁ ₁	2.31	2.41	2.51
A ₂	1.90	2.00	2.10
b ₁	1.15	1.20	1.25
b ₁ ₁	1.95	2.10	2.25
b ₂ ₂	2.95	3.10	3.25
c ₁	0.55	0.60	0.65
d ₁	20.90	21.00	21.10
D ₁	16.35	16.55	16.75
D ₂	1.05	1.20	1.35
E ₁	15.70	15.80	15.90
E ₂	13.10	13.25	13.40
E ₃	4.90	5.00	5.10
E ₄	2.40	2.50	2.60
e ₁	5.40	5.44	5.48
e ₂	19.80	19.92	20.10
e ₃ ₁	—	—	4.30
e ₃ P	3.70	3.80	3.90
e ₃ P ₁	3.50	3.60	3.70
e ₂ P	7.00	7.20	7.40
e ₃ P ₂	2.40	2.50	2.60
g	5.60	5.80	6.00
g ₅	6.05	6.15	6.25
T	9.80	10.00	10.20
u	6.00	6.20	6.40
θ ₁	5°	7°	9°
θ ₂	1°	3°	5°
θ ₃	13°	15°	17°